



ITW

Docket No.: M4065.0468/P468-B
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Phillip E. Byrd et al.

Application No.: 10/649,781

Confirmation No.: 5845

Filed: August 28, 2003

Art Unit: 2812

For: METHOD FOR TEMPORARILY
ISOLATING A DIE FROM A COMMON
CONDUCTOR TO
FACILITATE WAFER LEVEL TESTING

Examiner: Not Yet Assigned

STATUS INQUIRY

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

It is respectfully requested that the attorney named below be advised of the status of the above-identified application. Please advise us of when we might expect to receive an Office Action from the Patent and Trademark Office.

Dated: August 30, 2004

Respectfully submitted,

By 

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